

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10660751	WILLIAMS ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Patel, Jayesh A	2624	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	284,143,100,215,154,103,162,107,294	1/25/07	JP
348	412.1,14.16,14.15,19,20,143,36	1/25/07	JP
345	716	11/07/07	JP
701	225	11/07/07	JP

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
See attached East History. Also searched IEEE Xplore and NPL literature	1/25/07	JP
See attached east search history	11/15/07	JP

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>